## **EXPEDITED PROCEDURE** Examining Group Number 2800

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:

Craig K. Carlson-Stevermer

Examiner: Jermele M. Hollington

Serial No.:

10/622,849

Group Art Unit: 2829

Filed:

July 18, 2003

Docket No.: A126.114.102

Due Date:

February 22, 2007

Title:

WAFER STAGING PLATFORM FOR A WAFER INSPECTION SYSTEM

## AMENDMENT AND RESPONSE UNDER 37 C.F.R. 1.116

Mail Stop AF

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

This is responsive to the Final Office Action mailed November 22, 2006. Please amend the above-identified patent application as follows: